

<b>Notice of References Cited</b>	Application/Control No. 10/566,594		Applicant(s)/Patent Under Reexamination WALTHER ET AL.	
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*	B	US-6,614,392	09-2003	Howard, John	342/357.07
*	C	US-6,429,831	08-2002	Babb, Susan M.	343/895
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*	E	US-6,259,369	07-2001	Monico, Dominick L.	340/572.8
*	F	US-4,781,370	11-1988	Weisgerber, Willi	271/277
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*	K	US-6,343,550	02-2002	Feesler, Douglas W.	101/376
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*	M	US-4,933,123	06-1990	Yoshida et al.	264/446

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	N	WO03/022594	03-2003	Japan (PCT)	Yokota (see US 7,029,829)	430/281.1
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	U	Redinger, J., "An all-printed passive component technology for low-cost RFID", Device Research Conference Digest 2003; pp. 187-188
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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*	C	US-6,603,400	08-2003	Shoobridge, Richard Allen	340/572.1
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*	F	US-4,933,123	06-1990	Yoshida et al.	264/446
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